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Applications of "<u>Embedded - Microcontrollers</u>"

Details	
	Antina
Product Status	Active
Core Processor	PIC
Core Size	8-Bit
Speed	40MHz
Connectivity	CANbus, I <sup>2</sup> C, SPI, UART/USART
Peripherals	Brown-out Detect/Reset, HLVD, POR, PWM, WDT
Number of I/O	36
Program Memory Size	32KB (16K x 16)
Program Memory Type	FLASH
EEPROM Size	256 x 8
RAM Size	1.5K x 8
Voltage - Supply (Vcc/Vdd)	4.2V ~ 5.5V
Data Converters	A/D 11x10b
Oscillator Type	Internal
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	44-TQFP
Supplier Device Package	44-TQFP (10x10)
Purchase URL	https://www.e-xfl.com/product-detail/microchip-technology/pic18f4580-i-pt

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#### 3.4 RC Oscillator

For timing insensitive applications, the "RC" and "RCIO" device options offer additional cost savings. The actual oscillator frequency is a function of several factors:

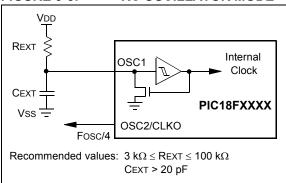
- · supply voltage
- values of the external resistor (REXT) and capacitor (CEXT)
- · operating temperature

Given the same device, operating voltage and temperature and component values, there will also be unit-to-unit frequency variations. These are due to factors such as:

- · normal manufacturing variation
- difference in lead frame capacitance between package types (especially for low CEXT values)
- variations within the tolerance of limits of REXT and CEXT

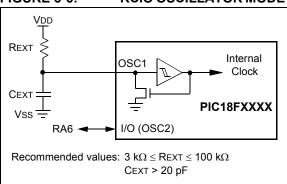
In the RC Oscillator mode, the oscillator frequency divided by 4 is available on the OSC2 pin. This signal may be used for test purposes or to synchronize other logic. Figure 3-5 shows how the R/C combination is connected.

FIGURE 3-5: RC OSCILLATOR MODE



The RCIO Oscillator mode (Figure 3-6) functions like the RC mode, except that the OSC2 pin becomes an additional general purpose I/O pin. The I/O pin becomes bit 6 of PORTA (RA6).

FIGURE 3-6: RCIO OSCILLATOR MODE



#### 3.5 PLL Frequency Multiplier

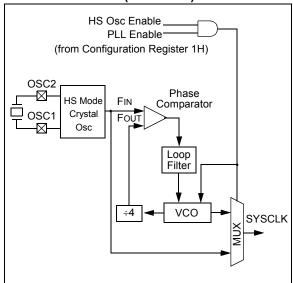
A Phase Locked Loop (PLL) circuit is provided as an option for users who wish to use a lower frequency oscillator circuit or to clock the device up to its highest rated frequency from a crystal oscillator. This may be useful for customers who are concerned with EMI due to high-frequency crystals or users who require higher clock speeds from an internal oscillator.

#### 3.5.1 HSPLL OSCILLATOR MODE

The HSPLL mode makes use of the HS mode oscillator for frequencies up to 10 MHz. A PLL then multiplies the oscillator output frequency by 4 to produce an internal clock frequency up to 40 MHz.

The PLL is only available to the crystal oscillator when the FOSC<3:0> Configuration bits are programmed for HSPLL mode (= 0110).

FIGURE 3-7: PLL BLOCK DIAGRAM (HS MODE)



#### 3.5.2 PLL AND INTOSC

The PLL is also available to the internal oscillator block in selected oscillator modes. In this configuration, the PLL is enabled in software and generates a clock output of up to 32 MHz. The operation of INTOSC with the PLL is described in **Section 3.6.4** "PLL in INTOSC **Modes**".

TABLE 5-4: INITIALIZATION CONDITIONS FOR ALL REGISTERS (CONTINUED)

Register	Applicable Devices			Power-or Brown-or	,	WDT RESET In	Resets, Reset, struction, Resets	Wake-up or Into	via WDT errupt	
RXB1SIDH	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	uuuu	uuuu
RXB1CON	2480	2580	4480	4580	000-	0000	000-	0000	uuu-	uuuu
TXB0D7	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	uuuu	uuuu
TXB0D6	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	uuuu	uuuu
TXB0D5	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	uuuu	uuuu
TXB0D4	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	uuuu	uuuu
TXB0D3	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	uuuu	uuuu
TXB0D2	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	uuuu	uuuu
TXB0D1	2480	2580	4480	4580	XXXX	xxxx	uuuu	uuuu	uuuu	uuuu
TXB0D0	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	uuuu	uuuu
TXB0DLC	2480	2580	4480	4580	-X	XXXX	-u	uuuu	-u	uuuu
TXB0EIDL	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	uuuu	uuuu
TXB0EIDH	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	-uuu	uuuu
TXB0SIDL	2480	2580	4480	4580	XXX-	x-xx	uuu-	u-uu	uuu-	u-uu
TXB0SIDH	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	uuuu	uuuu
TXB0CON	2480	2580	4480	4580	0000	0-00	0000	0-00	uuuu	u-uu
TXB1D7	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	uuuu	uuuu
TXB1D6	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	uuuu	uuuu
TXB1D5	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	uuuu	uuuu
TXB1D4	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	uuuu	uuuu
TXB1D3	2480	2580	4480	4580	XXXX	XXXX	uuuu	uuuu	uuuu	uuuu
TXB1D2	2480	2580	4480	4580	XXXX	xxxx	uuuu	uuuu	uuuu	uuuu
TXB1D1	2480	2580	4480	4580	XXXX	xxxx	uuuu	uuuu	uuuu	uuuu
TXB1D0	2480	2580	4480	4580	XXXX	xxxx	uuuu	uuuu	uuuu	uuuu
TXB1DLC	2480	2580	4480	4580	-X	xxxx	-u	uuuu	-u	uuuu
TXB1EIDL	2480	2580	4480	4580	XXXX	xxxx	uuuu	uuuu	uuuu	uuuu
TXB1EIDH	2480	2580	4480	4580	XXXX	xxxx	uuuu	uuuu	uuuu	uuuu
TXB1SIDL	2480	2580	4480	4580	XXX-	x-xx	uuu-	u-uu	uuu-	uu-u
TXB1SIDH	2480	2580	4480	4580	XXXX	xxxx	uuuu	uuuu	-uuu	uuuu
TXB1CON	2480	2580	4480	4580	0000	0-00	0000	0-00	uuuu	u-uu
TXB2D7	2480	2580	4480	4580	XXXX		uuuu	uuuu	0uuu	uuuu

**Legend:** u = unchanged, x = unknown, - = unimplemented bit, read as '0', <math>q = value depends on condition. Shaded cells indicate conditions do not apply for the designated device.

- Note 1: One or more bits in the INTCONx or PIRx registers will be affected (to cause wake-up).
  - 2: When the wake-up is due to an interrupt and the GIEL or GIEH bit is set, the PC is loaded with the interrupt vector (0008h or 0018h).
  - **3:** When the wake-up is due to an interrupt and the GIEL or GIEH bit is set, the TOSU, TOSH and TOSL are updated with the current value of the PC. The STKPTR is modified to point to the next location in the hardware stack.
  - **4:** See Table 5-3 for Reset value for specific condition.
  - **5:** Bits 6 and 7 of PORTA, LATA and TRISA are enabled, depending on the oscillator mode selected. When not enabled as PORTA pins, they are disabled and read '0'.
  - **6:** This register reads all '0's until ECAN™ technology is set up in Mode 1 or Mode 2.

TABLE 6-2: REGISTER FILE SUMMARY (PIC18F2480/2580/4480/4580) (CONTINUED)

File Name	Bit 7	Bit 6	Bit 5	Bit 4	Bit 3	Bit 2	Bit 1	Bit 0	Value on POR, BOR	Details on Page:
TXB1D1	TXB1D17	TXB1D16	TXB1D15	TXB1D14	TXB1D13	TXB1D12	TXB1D11	TXB1D10	xxxx xxxx	60, 290
TXB1D0	TXB1D07	TXB1D06	TXB1D05	TXB1D04	TXB1D03	TXB1D02	TXB1D01	TXB1D00	xxxx xxxx	60, 290
TXB1DLC	_	TXRTR	_	_	DLC3	DLC2	DLC1	DLC0	-x xxxx	60, 291
TXB1EIDL	EID7	EID6	EID5	EID4	EID3	EID2	EID1	EID0	xxxx xxxx	60, 290
TXB1EIDH	EID15	EID14	EID13	EID12	EID11	EID10	EID9	EID8	xxxx xxxx	60, 289
TXB1SIDL	SID2	SID1	SID0	-	EXIDE	ı	EID17	EID16	xxx- x-xx	60, 289
TXB1SIDH	SID10	SID9	SID8	SID7	SID6	SID5	SID4	SID3	xxxx xxxx	60, 289
TXB1CON	TXBIF	TXABT	TXLARB	TXERR	TXREQ	1	TXPRI1	TXPRI0	0000 0-00	60, 288
TXB2D7	TXB2D77	TXB2D76	TXB2D75	TXB2D74	TXB2D73	TXB2D72	TXB2D71	TXB2D70	xxxx xxxx	60, 290
TXB2D6	TXB2D67	TXB2D66	TXB2D65	TXB2D64	TXB2D63	TXB2D62	TXB2D61	TXB2D60	xxxx xxxx	61, 290
TXB2D5	TXB2D57	TXB2D56	TXB2D55	TXB2D54	TXB2D53	TXB2D52	TXB2D51	TXB2D50	xxxx xxxx	61, 290
TXB2D4	TXB2D47	TXB2D46	TXB2D45	TXB2D44	TXB2D43	TXB2D42	TXB2D41	TXB2D40	xxxx xxxx	61, 290
TXB2D3	TXB2D37	TXB2D36	TXB2D35	TXB2D34	TXB2D33	TXB2D32	TXB2D31	TXB2D30	xxxx xxxx	61, 290
TXB2D2	TXB2D27	TXB2D26	TXB2D25	TXB2D24	TXB2D23	TXB2D22	TXB2D21	TXB2D20	xxxx xxxx	61, 290
TXB2D1	TXB2D17	TXB2D16	TXB2D15	TXB2D14	TXB2D13	TXB2D12	TXB2D11	TXB2D10	xxxx xxxx	61, 290
TXB2D0	TXB2D07	TXB2D06	TXB2D05	TXB2D04	TXB2D03	TXB2D02	TXB2D01	TXB2D00	xxxx xxxx	61, 290
TXB2DLC	_	TXRTR	_	_	DLC3	DLC2	DLC1	DLC0	-x xxxx	61, 291
TXB2EIDL	EID7	EID6	EID5	EID4	EID3	EID2	EID1	EID0	xxxx xxxx	61, 290
TXB2EIDH	EID15	EID14	EID13	EID12	EID11	EID10	EID9	EID8	xxxx xxxx	61, 289
TXB2SIDL	SID2	SID1	SID0	_	EXIDE	_	EID17	EID16	xxxx x-xx	61, 289
TXB2SIDH	SID10	SID9	SID8	SID7	SID6	SID5	SID4	SID3	xxx- x-xx	61, 289
TXB2CON	TXBIF	TXABT	TXLARB	TXERR	TXREQ	_	TXPRI1	TXPRI0	0000 0-00	61, 288
RXM1EIDL	EID7	EID6	EID5	EID4	EID3	EID2	EID1	EID0	xxxx xxxx	61, 310
RXM1EIDH	EID15	EID14	EID13	EID12	EID11	EID10	EID9	EID8	xxxx xxxx	61, 310
RXM1SIDL	SID2	SID1	SID0	_	EXIDEN	_	EID17	EID16	xxx- x-xx	61, 310
RXM1SIDH	SID10	SID9	SID8	SID7	SID6	SID5	SID4	SID3	xxxx xxxx	61, 310
RXM0EIDL	EID7	EID6	EID5	EID4	EID3	EID2	EID1	EID0	xxxx xxxx	61, 310
RXM0EIDH	EID15	EID14	EID13	EID12	EID11	EID10	EID9	EID8	xxxx xxxx	61, 310
RXM0SIDL	SID2	SID1	SID0	_	EXIDEN	_	EID17	EID16	xxx- x-xx	61, 310
RXM0SIDH	SID10	SID9	SID8	SID7	SID6	SID5	SID4	SID3	xxxx xxxx	61, 309
RXF5EIDL	EID7	EID6	EID5	EID4	EID3	EID2	EID1	EID0	xxxx xxxx	61, 309
RXF5EIDH	EID15	EID14	EID13	EID12	EID11	EID10	EID9	EID8	xxxx xxxx	61, 309
RXF5SIDL	SID2	SID1	SID0	_	EXIDEN	_	EID17	EID16	xxx- x-xx	61, 308
RXF5SIDH	SID10	SID9	SID8	SID7	SID6	SID5	SID4	SID3	xxxx xxxx	61, 308
RXF4EIDL	EID7	EID6	EID5	EID4	EID3	EID2	EID1	EID0	xxxx xxxx	61, 309
RXF4EIDH	EID15	EID14	EID13	EID12	EID11	EID10	EID9	EID8	xxxx xxxx	61, 309
RXF4SIDL	SID2	SID1	SID0	_	EXIDEN	_	EID17	EID16	xxx- x-xx	61, 308
RXF4SIDH	SID10	SID9	SID8	SID7	SID6	SID5	SID4	SID3	xxxx xxxx	61, 308
RXF3EIDL	EID7	EID6	EID5	EID4	EID3	EID2	EID1	EID0	xxxx xxxx	61, 309
RXF3EIDH	EID15	EID14	EID13	EID12	EID11	EID10	EID9	EID8	xxxx xxxx	61, 309
RXF3SIDL	SID2	SID1	SID0		EXIDEN	_	EID17	EID16	xxx- x-xx	62, 308

 $\textbf{Legend:} \quad x = \text{unknown}, \ u = \text{unchanged}, \ - = \text{unimplemented}, \ q = \text{value depends on condition}$ 

- Note 1: Bit 21 of the PC is only available in Test mode and Serial Programming modes.
  - 2: The SBOREN bit is only available when CONFIG2L<1:0> = 01; otherwise, it is disabled and reads as '0'. See Section 5.4 "Brown-out Reset (BOR)".
  - 3: These registers and/or bits are not implemented on PIC18F2X80 devices and are read as '0'. Reset values are shown for PIC18F4X80 devices; individual unimplemented bits should be interpreted as '—'.
  - 4: The PLLEN bit is only available in specific oscillator configuration; otherwise, it is disabled and reads as '0'. See Section 3.6.4 "PLL in INTOSC Modes".
  - 5: The RE3 bit is only available when Master Clear Reset is disabled (CONFIG3H<7> = 0); otherwise, RE3 reads as '0'. This bit is read-only.
  - **6:** RA6/RA7 and their associated latch and direction bits are individually configured as port pins based on various primary oscillator modes. When disabled, these bits read as '0'.
  - 7: CAN bits have multiple functions depending on the selected mode of the CAN module.
  - 8: This register reads all '0's until the ECAN™ technology is set up in Mode 1 or Mode 2.
  - 9: These registers are available on PIC18F4X80 devices only.

#### 7.0 FLASH PROGRAM MEMORY

The Flash program memory is readable, writable and erasable, during normal operation over the entire VDD range.

A read from program memory is executed on one byte at a time. A write to program memory is executed on blocks of 8 bytes at a time. Program memory is erased in blocks of 64 bytes at a time. A bulk erase operation may not be issued from user code.

Writing or erasing program memory will cease instruction fetches until the operation is complete. The program memory cannot be accessed during the write or erase, therefore, code cannot execute. An internal programming timer terminates program memory writes and erases.

#### 7.1 **Table Reads and Table Writes**

In order to read and write program memory, there are two operations that allow the processor to move bytes between the program memory space and the data RAM:

- Table Read (TBLRD)
- Table Write (TBLWT)

The program memory space is 16 bits wide, while the data RAM space is 8 bits wide. Table reads and table writes move data between these two memory spaces through an 8-bit register (TABLAT).

Table read operations retrieve data from program memory and place it into the data RAM space. Figure 7-1 shows the operation of a table read with program memory and data RAM.

Table write operations store data from the data memory space into holding registers in program memory. The procedure to write the contents of the holding registers into program memory is detailed in Section 7.5 "Writing to Flash Program Memory". Figure 7-2 shows the operation of a table write with program memory and data RAM.

Table operations work with byte entities. A table block containing data, rather than program instructions, is not required to be word aligned. Therefore, a table block can start and end at any byte address. If a table write is being used to write executable code into program memory, program instructions will need to be word aligned.

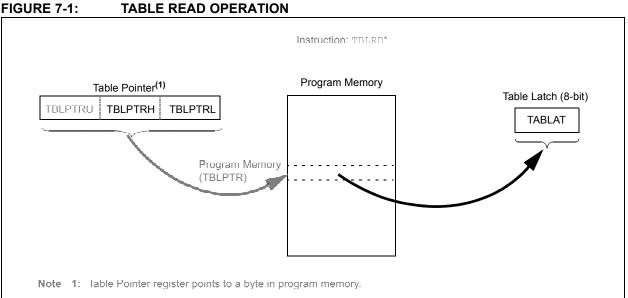


FIGURE 18-27: BUS COLLISION DURING START CONDITION (SCL = 0)

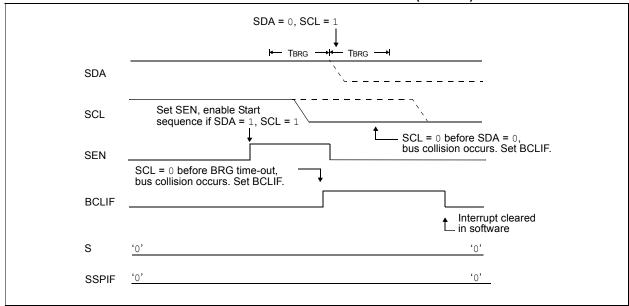
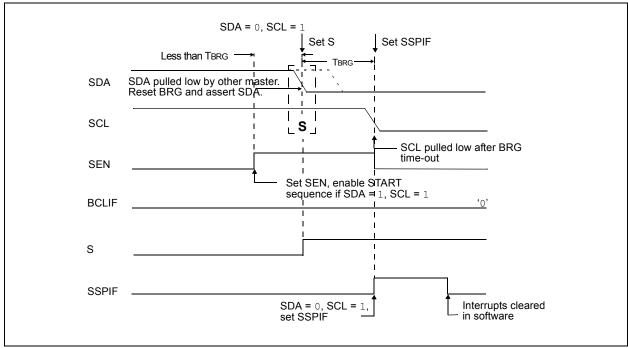


FIGURE 18-28: BRG RESET DUE TO SDA ARBITRATION DURING START CONDITION



## 18.4.17.2 Bus Collision During a Repeated Start Condition

During a Repeated Start condition, a bus collision occurs if:

- A low level is sampled on SDA when SCL goes from a low level to a high level.
- b) SCL goes low before SDA is asserted low, indicating that another master is attempting to transmit a data '1'.

When the user deasserts SDA and the pin is allowed to float high, the BRG is loaded with SSPADD<6:0> and counts down to 0. The SCL pin is then deasserted and when sampled high, the SDA pin is sampled.

If SDA is low, a bus collision has occurred (i.e., another master is attempting to transmit a data '0', see Figure 18-29). If SDA is sampled high, the BRG is reloaded and begins counting. If SDA goes from high-to-low before the BRG times out, no bus collision occurs because no two masters can assert SDA at exactly the same time.

If SCL goes from high-to-low before the BRG times out, and SDA has not already been asserted, a bus collision occurs. In this case, another master is attempting to transmit a data '1' during the Repeated Start condition, see Figure 18-30.

If, at the end of the BRG time-out, both SCL and SDA are still high, the SDA pin is driven low and the BRG is reloaded and begins counting. At the end of the count regardless of the status of the SCL pin, the SCL pin is driven low and the Repeated Start condition is complete.

FIGURE 18-29: BUS COLLISION DURING A REPEATED START CONDITION (CASE 1)

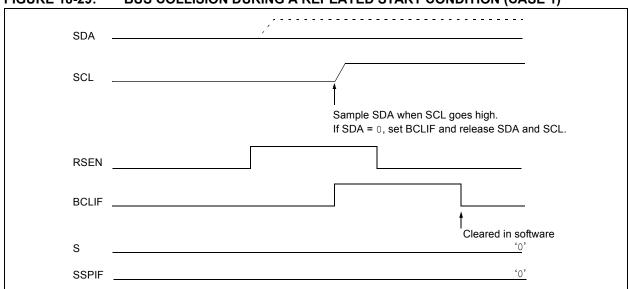
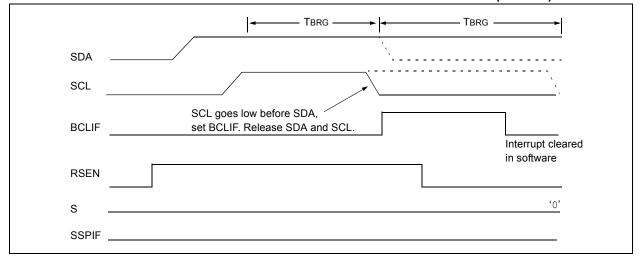


FIGURE 18-30: BUS COLLISION DURING REPEATED START CONDITION (CASE 2)



#### 19.1.3 AUTO-BAUD RATE DETECT

The Enhanced USART module supports the automatic detection and calibration of baud rate. This feature is active only in Asynchronous mode and while the WUE bit is clear.

The automatic baud rate measurement sequence (Figure 19-1) begins whenever a Start bit is received and the ABDEN bit is set. The calculation is self-averaging.

In the Auto-Baud Rate Detect (ABD) mode, the clock to the BRG is reversed. Rather than the BRG clocking the incoming RX signal, the RX signal is timing the BRG. In ABD mode, the internal Baud Rate Generator is used as a counter to time the bit period of the incoming serial byte stream.

Once the ABDEN bit is set, the state machine will clear the BRG and look for a Start bit. The Auto-Baud Rate Detection must receive a byte with the value 55h (ASCII "U", which is also the LIN/J2602 bus Sync character) in order to calculate the proper bit rate. The measurement is taken over both a low and a high bit time in order to minimize any effects caused by asymmetry of the incoming signal. After a Start bit, the SPBRG begins counting up, using the preselected clock source on the first rising edge of RX. After eight bits on the RX pin or the fifth rising edge, an accumulated value totalling the proper BRG period is left in the SPBRGH:SPBRG register pair. Once the 5th edge is seen (this should correspond to the Stop bit), the ABDEN bit is automatically cleared.

If a rollover of the BRG occurs (an overflow from FFFFh to 0000h), the event is trapped by the ABDOVF status bit (BAUDCON<7>). It is set in hardware by BRG rollovers and can be set or cleared by the user in software. ABD mode remains active after rollover events and the ABDEN bit remains set (Figure 19-2).

While calibrating the baud rate period, the BRG registers are clocked at 1/8th the preconfigured clock rate. Note that the BRG clock can be configured by the BRG16 and BRGH bits. The BRG16 bit must be set to use both SPBRG1 and SPBRGH1 as a 16-bit counter. This allows the user to verify that no carry occurred for 8-bit modes by checking for 00h in the SPBRGH register. Refer to Table 19-4 for counter clock rates to the BRG.

While the ABD sequence takes place, the EUSART state machine is held in Idle. The RCIF interrupt is set once the fifth rising edge on RX is detected. The value in the RCREG needs to be read to clear the RCIF interrupt. The contents of RCREG should be discarded.

- **Note 1:** If the WUE bit is set with the ABDEN bit, Auto-Baud Rate Detection will occur on the byte *following* the Break character.
  - 2: It is up to the user to determine that the incoming character baud rate is within the range of the selected BRG clock source. Some combinations of oscillator frequency and EUSART baud rates are not possible due to bit error rates. Overall system timing and communication baud rates must be taken into consideration when using the Auto-Baud Rate Detection feature.
  - **3:** To maximize baud rate range, it is recommended to set the BRG16 bit if the auto-baud feature is used.

TABLE 19-4: BRG COUNTER CLOCK RATES

BRG16	BRGH	BRG Counter Clock					
0	0	Fosc/512					
0	1	Fosc/128					
1	0	Fosc/128					
1	1	Fosc/32					

#### 19.1.3.1 ABD and EUSART Transmission

Since the BRG clock is reversed during ABD acquisition, the EUSART transmitter cannot be used during ABD. This means that whenever the ABDEN bit is set, TXREG cannot be written to. Users should also ensure that ABDEN does not become set during a transmit sequence. Failing to do this may result in unpredictable EUSART operation.

## 20.4 Operation in Power-Managed Modes

The selection of the automatic acquisition time and A/D conversion clock is determined in part, by the clock source and frequency while in a power-managed mode

If the A/D is expected to operate while the device is in a power-managed mode, the ACQT<2:0> and ADCS<2:0> bits in ADCON2 should be updated in accordance with the clock source to be used in that mode. After entering the mode, an A/D acquisition or conversion may be started. Once started, the device should continue to be clocked by the same clock source until the conversion has been completed.

If desired, the device may be placed into the corresponding Idle mode during the conversion. If the device clock frequency is less than 1 MHz, the A/D RC clock source should be selected.

Operation in the Sleep mode requires the A/D FRC clock to be selected. If bits, ACQT<2:0>, are set to '000' and a conversion is started, the conversion will be delayed one instruction cycle to allow execution of the SLEEP instruction and entry to Sleep mode. The IDLEN bit (OSCCON<7>) must have already been cleared prior to starting the conversion.

#### 20.5 Configuring Analog Port Pins

The ADCON1, TRISA, TRISB and TRISE registers all configure the A/D port pins. The port pins needed as analog inputs must have their corresponding TRIS bits set (input). If the TRIS bit is cleared (output), the digital output level (VOH or VOL) will be converted.

The A/D operation is independent of the state of the CHS<3:0> bits and the TRIS bits.

- Note 1: When reading the PORT register, all pins configured as analog input channels will read as cleared (a low level). Pins configured as digital inputs will convert an analog input. Analog levels on a digitally configured input will be accurately converted.
  - 2: Analog levels on any pin defined as a digital input may cause the digital input buffer to consume current out of the device's specification limits.
  - **3:** The PBADEN bit in Configuration Register 3H configures PORTB pins to reset as analog or digital pins by controlling how the PCFG bits in ADCON1 are reset.

## 24.2.2 DEDICATED CAN TRANSMIT BUFFER REGISTERS

This section describes the dedicated CAN Transmit Buffer registers and their associated control registers.

#### REGISTER 24-5: TXBnCON: TRANSMIT BUFFER n CONTROL REGISTERS $[0 \le n \le 2]$

Mada 0	U-0	R-0	R-0	R-0	R/W-0	U-0	R/W-0	R/W-0
Mode 0	_	TXABT <sup>(1)</sup>	TXLARB <sup>(1)</sup>	TXERR <sup>(1)</sup>	TXREQ <sup>(2)</sup>	_	TXPRI1 <sup>(3)</sup>	TXPRI0 <sup>(3)</sup>

Mode 1,2	R/C-0	R-0	R-0	R-0	R/W-0	U-0	R/W-0	R/W-0
Wiode 1,2	TXBIF	TXABT <sup>(1)</sup>	TXLARB <sup>(1)</sup>	TXERR <sup>(1)</sup>	TXREQ <sup>(2)</sup>	_	TXPRI1 <sup>(3)</sup>	TXPRI0 <sup>(3)</sup>
	bit 7							bit 0

Legend:	C = Clearable bit		
R = Readable bit	W = Writable bit	U = Unimplemented bit,	read as '0'
-n = Value at POR	'1' = Bit is set	'0' = Bit is cleared	x = Bit is unknown

bit 7 Mode 0:

Unimplemented: Read as '0'

Mode 1, 2:

TXBIF: Transmit Buffer Interrupt Flag bit

1 = Transmit buffer has completed transmission of message and may be reloaded

0 = Transmit buffer has not completed transmission of a message

bit 6 TXABT: Transmission Aborted Status bit<sup>(1)</sup>

1 = Message was aborted

0 = Message was not aborted

bit 5 **TXLARB:** Transmission Lost Arbitration Status bit<sup>(1)</sup>

1 = Message lost arbitration while being sent

0 = Message did not lose arbitration while being sent

bit 4 **TXERR:** Transmission Error Detected Status bit<sup>(1)</sup>

1 = A bus error occurred while the message was being sent

0 = A bus error did not occur while the message was being sent

bit 3 **TXREQ:** Transmit Request Status bit<sup>(2)</sup>

1 = Requests sending a message. Clears the TXABT, TXLARB and TXERR bits.

0 = Automatically cleared when the message is successfully sent

bit 2 Unimplemented: Read as '0'

bit 1-0 **TXPRI<1:0>:** Transmit Priority bits<sup>(3)</sup>

11 = Priority Level 3 (highest priority)

10 = Priority Level 2

01 = Priority Level 1

00 = Priority Level 0 (lowest priority)

Note 1: This bit is automatically cleared when TXREQ is set.

2: While TXREQ is set, Transmit Buffer registers remain read-only. Clearing this bit in software while the bit is set will request a message abort.

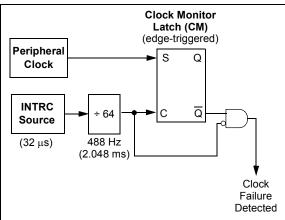
**3:** These bits define the order in which transmit buffers will be transferred. They do not alter the CAN message identifier.

#### 25.4 Fail-Safe Clock Monitor

The Fail-Safe Clock Monitor (FSCM) allows the microcontroller to continue operation in the event of an external oscillator failure by automatically switching the device clock to the internal oscillator block. The FSCM function is enabled by setting the FCMEN Configuration bit

When FSCM is enabled, the INTRC oscillator runs at all times to monitor clocks to peripherals and provide a backup clock in the event of a clock failure. Clock monitoring (shown in Figure 25-3) is accomplished by creating a sample clock signal, which is the INTRC output divided by 64. This allows ample time between FSCM sample clocks for a peripheral clock edge to occur. The peripheral device clock and the sample clock are presented as inputs to the Clock Monitor (CM) latch. The CM is set on the falling edge of the device clock source, but cleared on the rising edge of the sample clock.

FIGURE 25-3: FSCM BLOCK DIAGRAM



Clock failure is tested for on the falling edge of the sample clock. If a sample clock falling edge occurs while CM is still set, a clock failure has been detected (Figure 25-4). This causes the following:

- the FSCM generates an oscillator fail interrupt by setting bit, OSCFIF (PIR2<7>);
- the device clock source is switched to the internal oscillator block (OSCCON is not updated to show the current clock source – this is the Fail-Safe condition); and
- · the WDT is reset.

During switchover, the postscaler frequency from the internal oscillator block may not be sufficiently stable for timing-sensitive applications. In these cases, it may be desirable to select another clock configuration and enter an alternate power-managed mode. This can be done to attempt a partial recovery or execute a controlled shutdown. See Section 4.1.4 "Multiple Sleep Commands" and Section 25.3.1 "Special Considerations for Using Two-Speed Start-up" for more details.

To use a higher clock speed on wake-up, the INTOSC or postscaler clock sources can be selected to provide a higher clock speed by setting bits, IRCF<2:0>, immediately after Reset. For wake-ups from Sleep, the INTOSC or postscaler clock sources can be selected by setting the IRCF<2:0> bits prior to entering Sleep mode.

The FSCM will detect failures of the primary or secondary clock sources only. If the internal oscillator block fails, no failure would be detected, nor would any action be possible.

#### 25.4.1 FSCM AND THE WATCHDOG TIMER

Both the FSCM and the WDT are clocked by the INTRC oscillator. Since the WDT operates with a separate divider and counter, disabling the WDT has no effect on the operation of the INTRC oscillator when the FSCM is enabled.

As already noted, the clock source is switched to the INTOSC clock when a clock failure is detected. Depending on the frequency selected by the IRCF<2:0> bits, this may mean a substantial change in the speed of code execution. If the WDT is enabled with a small prescale value, a decrease in clock speed allows a WDT time-out to occur and a subsequent device Reset. For this reason, Fail-Safe Clock events also reset the WDT and postscaler, allowing it to start timing from when execution speed was changed and decreasing the likelihood of an erroneous time-out.

#### 25.4.2 EXITING FAIL-SAFE OPERATION

The Fail-Safe condition is terminated by either a device Reset or by entering a power-managed mode. On Reset, the controller starts the primary clock source specified in Configuration Register 1H (with any required start-up delays that are required for the oscillator mode, such as OST or PLL timer). The INTOSC multiplexer provides the device clock until the primary clock source becomes ready (similar to a Two-Speed Start-up). The clock source is then switched to the primary clock (indicated by the OSTS bit in the OSCCON register becoming set). The Fail-Safe Clock Monitor then resumes monitoring the peripheral clock.

The primary clock source may never become ready during start-up. In this case, operation is clocked by the INTOSC multiplexer. The OSCCON register will remain in its Reset state until a power-managed mode is entered.

ADDWFC	ADD W and Carry bit to f									
Syntax:	ADDWFC	f {,d {,	a}}							
Operands:	$0 \le f \le 258$ $d \in [0,1]$ $a \in [0,1]$	5								
Operation:	(W) + (f) +	$(C) \rightarrow d\epsilon$	est							
Status Affected:	N,OV, C, DC, Z									
Encoding:	0010	00da	ffff	ffff						
Description:	Add W, the Carry flag and data memory location 'f'. If 'd' is '0', the result is placed in W. If 'd' is '1', the result is placed in data memory location 'f'.  If 'a' is '0', the Access Bank is selected. If 'a' is '1', the BSR is used to select the GPR bank.  If 'a' is '0' and the extended instruction set is enabled, this instruction operates in Indexed Literal Offset Addressing mode whenever f ≤ 95 (5Fh). See Section 26.2.3 "Byte-Oriented and Bit-Oriented Instructions in Indexed									
Words:	1									
Cycles:	1									
Q Cycle Activity:										
Q1	Q2	Q3	1	Q4						

Process

Data

REG, 0, 1

Write to

destination

AND	LW	AND Lite	AND Literal with W								
Synta	ax:	ANDLW	k								
Oper	ands:	$0 \le k \le 255$	5								
Oper	ation:	(W) .AND.	$k\toW$								
Statu	s Affected:	N, Z	N, Z								
Enco	ding:	0000	1011	kkkk	kkkk						
Desc	ription:		The contents of W are ANDed with the 8-bit literal 'k'. The result is placed in W.								
Word	ls:	1	1								
Cycle	es:	1									
QC	ycle Activity:										
Q1		Q2	Q3	3	Q4						
	Decode	Read literal 'k'	Proce Data		ite to W						
		•									

05Fh

Example: ANDLW

Before Instruction

W = A3h

After Instruction

W = 03h

Example:

Decode

Carry bit = 1 REG = 02h W = 4Dh

Read register 'f'

ADDWFC

After Instruction

Before Instruction

 $\begin{array}{ccc} \text{Carry bit} & = & 0 \\ \text{REG} & = & 02h \\ \text{W} & = & 50h \end{array}$ 

INC	sz	Incremen	t f, Skip if 0		INF	SNZ	Incremen	t f, Skip if n	ot 0		
Synta	ax:	INCFSZ f	{,d {,a}}		Synt	ax:	INFSNZ f	{,d {,a}}			
Oper	ands:	$0 \le f \le 255$			Ope	rands:	$0 \leq f \leq 255$				
•		$d \in \left[0,1\right]$					$d \in [0,1]$				
		a ∈ [0,1]			0		a ∈ [0,1]				
Oper	ation:	$(f) + 1 \rightarrow de$			Ope	ration:	(f) + 1 → de skip if resul	•			
		skip if resul	<b>t =</b> 0		Stati	us Affected:	None	0			
Statu	s Affected:	None				oding:					
Enco	ding:	0011	11da ff	ff ffff		cription:		ts of register "			
Desc	ription:		ts of register "		DCS	onpuon.		d. If 'd' is '0', t			
			d. If 'd' is '0', t				placed in W	/. If 'd' is '1', th	ne result is		
		•	/. If 'd' is '1', th k in register 'f'				•	k in register 'f'			
		•	is '0', the nex					is not '0', the which is alread			
			eady fetched i					and a NOP is e	•		
			is executed in: le instruction.	stead, making			instead, ma	iking it a two-d	cycle		
		,		nk is selected.				he Access Ba	nk is selected.		
		•		d to select the			,		d to select the		
		GPR bank.					GPR bank.				
			nd the extend	ed instruction ction operates				If 'a' is '0' and the extended instruction set is enabled, this instruction operates			
			Literal Offset A	•				ed, this instru Literal Offset <i>I</i>			
		mode when	never $f \le 95$ (5	Fh). See				ever f ≤ 95 (5			
			.2.3 "Byte-Or ed Instruction				Section 26.2.3 "Byte-Oriented and Bit-Oriented Instructions in Indexed				
			set Mode" for					ed Instruction set Mode" for			
Word	s:	1			Word	ds:	1				
Cycle	es:	1(2)			Cycl	es:	1(2)				
			cycles if skip a				Note: 3 d	cycles if skip a	nd followed		
		by	a 2-word instr	uction.			by	a 2-word instr	ruction.		
Q C	ycle Activity:				QC	cycle Activity:					
i	Q1	Q2	Q3	Q4		Q1	Q2	Q3	Q4		
	Decode	Read	Process	Write to		Decode	Read	Process	Write to		
lf sk	in·	register 'f'	Data	destination	lf ol	L	register 'f'	Data	destination		
11 31	ιρ. Q1	Q2	Q3	Q4	If sk	•	00	02	04		
	No	No	No	No		Q1 No	Q2 No	Q3 No	Q4 No		
	operation	operation	operation	operation		operation	operation	operation	operation		
lf sk	ip and followe	d by 2-word in:	struction:		If sk	<u> </u>	d by 2-word in				
	Q1	Q2	Q3	Q4		Q1	Q2	Q3	Q4		
	No	No	No	No		No	No	No	No		
	operation	operation	operation	operation		operation	operation	operation	operation		
	No operation	No operation	No operation	No operation		No operation	No operation	No operation	No operation		
Exam	Example: HERE INCFSZ CNT, 1, 0 NZERO : ZERO :		<u>Exar</u>			G, 1, 0					
	Before Instruc					Before Instruc					
	PC		(HERE)			PC After Instruction		(HERE)			
	After Instruction	on = CNT+ <sup>-</sup>	1			REG	= REG +	1			
	If CNT	= 0;				If REG	<b>≠</b> 0;				
	PC If CNT	= Address ≠ 0;	S (ZERO)			PC If REG	= Address = 0;	(NZERO)			
	PC		S (NZERO)			PC	= Address	S (ZERO)			

#### 28.2 DC Characteristics: Power-Down and Supply Current

PIC18F2480/2580/4480/4580 (Industrial, Extended) PIC18LF2480/2580/4480/4580 (Industrial) (Continued)

PIC18LF	<b>2480/2580/4480/4580</b> strial)	Standard Operating Conditions (unless otherwise stated)  Operating temperature -40°C ≤ TA ≤ +85°C for industrial								
	<b>480/2580/4480/4580</b> strial, Extended)		rd Oper ng temp		-40°C ≤ TA	s otherwise stated $A \le +85^{\circ}\text{C}$ for indust $A \le +125^{\circ}\text{C}$ for extending	rial			
Param No.	Device	Тур	Max	Units	Conditions					
	Supply Current (IDD) <sup>(2,3)</sup>									
	PIC18LF2X80/4X80	300	390	μΑ	-40°C					
		320	390	μΑ	+25°C	VDD = 2.0V				
		330	390	μΑ	+85°C					
	PIC18LF2X80/4X80	450	550	μΑ	-40°C					
		470	550	μΑ	+25°C	VDD = 3.0V	Fosc = 1 MHz ( <b>RC_IDLE</b> mode,			
		490	550	μА	+85°C		Internal oscillator source)			
	All devices	840	1030	μА	-40°C		,			
		880	1030	μΑ	+25°C	VDD = 5.0V				
		900	1030	μА	+85°C	VDD = 5.0 V				
	Extended devices only	2.8	3.2	mA	+125°C					
	PIC18LF2X80/4X80	760	1050	μΑ	-40°C					
		790	1050	μΑ	+25°C	VDD = 2.0V				
		810	1050	μΑ	+85°C					
	PIC18LF2X80/4X80	1.2	1.5	mA	-40°C					
		1.2	1.5	mA	+25°C	VDD = 3.0V	Fosc = 4 MHz ( <b>RC IDLE</b> mode,			
		1.3	1.5	mA	+85°C		Internal oscillator source)			
	All devices	2.2	2.7	mA	-40°C					
		2.3	2.7	mA	+25°C	VDD = 5.0V				
		2.3	2.7	mA	+85°C	133 0.01				
	Extended devices only	4.7	5.5	mA	+125°C					
	PIC18LF2X80/4X80	410	550	μА	-40°C					
		420	550	μА	+25°C	VDD = 2.0V				
		420	550	μΑ	+85°C					
	PIC18LF2X80/4X80	870	830	μΑ	-40°C	4	Fosc = 1 MHz			
		770	830	μΑ	+25°C	VDD = 3.0V	(PRI RUN,			
		720	830	μΑ	+85°C		EC oscillator)			
	All devices	1.8	3.3	mA	-40°C	4				
		1.6	3.3	mA	+25°C	VDD = 5.0V				
		1.5	3.3	mA	+85°C	4				
	Extended devices only	1.5	3.3	mA	+125°C					

Legend: Shading of rows is to assist in readability of the table.

Note 1: The power-down current in Sleep mode does not depend on the oscillator type. Power-down current is measured with the part in Sleep mode, with all I/O pins in high-impedance state and tied to VDD or VSs and all features that add delta current disabled (such as WDT, Timer1 Oscillator, BOR, etc.).

2: The supply current is mainly a function of operating voltage, frequency and mode. Other factors, such as I/O pin loading and switching rate, oscillator type and circuit, internal code execution pattern and temperature, also have an impact on the current consumption. The test conditions for all IDD measurements in active operation mode are:

OSC1 = external square wave, from rail-to-rail; all I/O pins tri-stated, pulled to VDD;

MCLR = VDD; WDT enabled/disabled as specified.

- 3: For RC oscillator configurations, current through REXT is not included. The current through the resistor can be estimated by the formula, Ir = VDD/2REXT (mA), with REXT in kΩ.
- 4: Standard low-cost 32 kHz crystals have an operating temperature range of -10°C to +70°C. Extended temperature crystals are available at a much higher cost.

28.2 DC Characteristics: Power-Down and Supply Current

PIC18F2480/2580/4480/4580 (Industrial, Extended) PIC18LF2480/2580/4480/4580 (Industrial) (Continued)

	PIC18LF2480/2580/4480/4580 (Industrial)		Standard Operating Conditions (unless otherwise stated) Operating temperature $-40^{\circ}\text{C} \le \text{TA} \le +85^{\circ}\text{C}$ for industrial									
	<b>480/2580/4480/4580</b> strial, Extended)	Standard Operating Conditions (unless otherwise stated)  Operating temperature $-40^{\circ}\text{C} \le \text{TA} \le +85^{\circ}\text{C}$ for industrial $-40^{\circ}\text{C} \le \text{TA} \le +125^{\circ}\text{C}$ for extended										
Param No.	Device	Тур	Max	Units	Conditions							
	Supply Current (IDD) <sup>(2,3)</sup>	()										
	PIC18LF2X80/4X80	19	44	μА	-40°C							
		20	44	μΑ	+25°C	V <sub>DD</sub> = 2.0V						
		22	44	μА	+85°C							
	PIC18LF2X80/4X80	56	71	μА	-40°C		Fosc = 32 kHz					
		45	71	μΑ	+25°C	VDD = 3.0V	(SEC_RUN mode,					
		41	71	μΑ	+85°C		Timer1 as clock) <sup>(4)</sup>					
	All devices	140	165	μΑ	-40°C							
		106	165	μΑ	+25°C	V <sub>DD</sub> = 5.0V						
		95	165	μΑ	+85°C							
	PIC18LF2X80/4X80	6.1	13	μΑ	-40°C							
		6.6	13	μΑ	+25°C	V <sub>DD</sub> = 2.0V						
		7.7	13	μА	+85°C							
	PIC18LF2X80/4X80	9.3	33	μΑ	-40°C		Fosc = 32 kHz					
		9.4	33	μА	+25°C	VDD = 3.0V	(SEC_IDLE mode,					
		11	33	μА	+85°C		Timer1 as clock) <sup>(4)</sup>					
	All devices	17	50	μА	-40°C	_						
		17	50	μА	+25°C	VDD = 5.0V						
		20	50	μΑ	+85°C							

Legend: Shading of rows is to assist in readability of the table.

- Note 1: The power-down current in Sleep mode does not depend on the oscillator type. Power-down current is measured with the part in Sleep mode, with all I/O pins in high-impedance state and tied to VDD or Vss and all features that add delta current disabled (such as WDT, Timer1 Oscillator, BOR, etc.).
  - 2: The supply current is mainly a function of operating voltage, frequency and mode. Other factors, such as I/O pin loading and switching rate, oscillator type and circuit, internal code execution pattern and temperature, also have an impact on the current consumption. The test conditions for all IDD measurements in active operation mode are:

 $\underline{\mathsf{OSC1}}$  = external square wave, from rail-to-rail; all I/O pins tri-stated, pulled to VDD;

MCLR = VDD; WDT enabled/disabled as specified.

- 3: For RC oscillator configurations, current through REXT is not included. The current through the resistor can be estimated by the formula, Ir = VDD/2REXT (mA), with REXT in kΩ.
- 4: Standard low-cost 32 kHz crystals have an operating temperature range of -10°C to +70°C. Extended temperature crystals are available at a much higher cost.

FIGURE 28-6: CLKO AND I/O TIMING

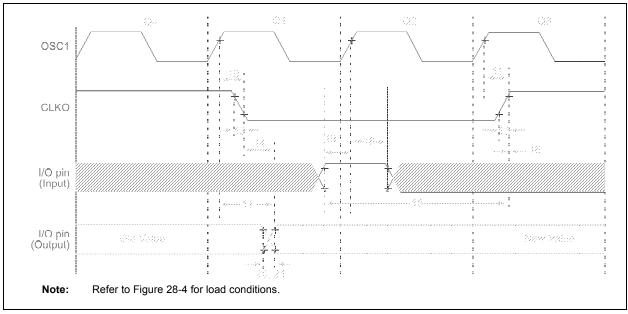


TABLE 28-9: CLKO AND I/O TIMING REQUIREMENTS

Param No.	Symbol	Characteristic		Min	Тур	Max	Units	Conditions
10	TosH2cĸL	OSC1 ↑ to CLKO ↓		_	75	200	ns	(Note 1)
11	TosH2ck H	OSC1 ↑ to CLKO ↑		_	75	200	ns	(Note 1)
12	TckR	CLKO Rise Time		_	35	100	ns	(Note 1)
13	TckF	CLKO Fall Time		_	35	100	ns	(Note 1)
14	TckL2ioV	CLKO ↓ to Port Out Valid		_		0.5 Tcy + 20	ns	(Note 1)
15	TioV2ckH	Port In Valid before CLKO ↑		0.25 Tcy + 25	_	_	ns	(Note 1)
16	TckH2iol	Port In Hold after CLKO ↑		0	_	_	ns	(Note 1)
17	TosH2IoV	OSC1 ↑ (Q1 cycle) to Port Out Valid		_	50	150	ns	
18	TosH2ıol	OSC1 ↑ (Q2 cycle) to Port	PIC18FXXXX	100	_	_	ns	
18A		Input Invalid (I/O in hold time)	PIC18 <b>LF</b> XXXX	200	_	_	ns	VDD = 2.0V
19	TioV2osH	Port Input Valid to OSC1 ↑ (I/O in setup time)		0	_	_	ns	
20	TioR	Port Output Rise Time	PIC18FXXXX	_	10	25	ns	
20A			PIC18 <b>LF</b> XXXX	_	_	60	ns	VDD = 2.0V
21	TioF	Port Output Fall Time	PIC18FXXXX	_	10	25	ns	
21A			PIC18 <b>LF</b> XXXX	_		60	ns	VDD = 2.0V
22†	TINP	INTx Pin High or Low Time		Tcy	_	_	ns	
23†	TRBP	RB<7:4> Change INTx High or Low Time		Tcy		_	ns	
24†	TRCP	RC<7:4> Change INTx High or Low Time		20			ns	

<sup>†</sup> These parameters are asynchronous events not related to any internal clock edges.

Note 1: Measurements are taken in RC mode, where CLKO output is 4 x Tosc.

TABLE 28-24: A/D CONVERTER CHARACTERISTICS: PIC18F2480/2580/4480/4580 (INDUSTRIAL) PIC18LF2480/2580/4480/4580 (INDUSTRIAL)

Param No.	Sym	Charac	teristic	Min	Тур	Max	Units	Conditions	
A01	NR	Resolution		_	_	10	bit	$\Delta V$ REF $\geq 3.0 V$	
A03	EIL	Integral Linearity Error		_	_	<±1	LSb	$\Delta V$ REF $\geq 3.0V$	
A04	Edl	Differential Linearity Error		_	_	<±1	LSb	$\Delta V$ REF $\geq 3.0V$	
A06	Eoff	Offset Error		_	_	<±2	LSb	$\Delta V$ REF $\geq 3.0V$	
A07	Egn	Gain Error				<±1	LSb	LSb ∆VREF≥3.0V	
A10	_	Monotonicity	Guaranteed <sup>(1)</sup>			_			
A20	ΔVREF	Reference Voltage Range (VREFH – VREFL)		3	_	AVDD – AVSS	V	For 10-bit resolution	
A21	VREFH	Reference Voltage High		AVss + 3.0V	_	AVDD + 0.3V	V	For 10-bit resolution	
A22	VREFL	Reference Voltage Low		AVss – 0.3V	_	AVDD - 3.0V	V	For 10-bit resolution	
A25	Vain	Analog Input Voltage		VREFL	_	VREFH	V		
A28	AVDD	Analog Supply Voltage		VDD - 0.3	_	VDD + 0.3	V		
A29	AVss	Analog Supply Voltage		Vss - 0.3	_	Vss + 0.3	V		
A30	ZAIN	Recommended Impedance of Analog Voltage Source		_	_	2.5	kΩ		
A40	lad	A/D Conversion Current (VDD)	PIC18 <b>F</b> XXXX	_	180	_	μΑ	Average current consumption when A/D is on (Note 2)	
			PIC18LFXXXX	_	90	_	μА	VDD = 2.0V; average current consumption when A/D is on (Note 2)	
A50	IREF	VREF Input Current (Note 3)			_	±5 ±150	μ <b>Α</b> μ <b>Α</b>	During VAIN acquisition. During A/D conversion cycle.	

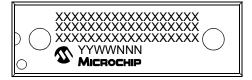
**Note 1:** The A/D conversion result never decreases with an increase in the input voltage and has no missing codes.

<sup>2:</sup> When A/D is off, it will not consume any current other than minor leakage current. The power-down current spec includes any such leakage from the A/D module.

**<sup>3:</sup>** VREFH current is from RA3/AN3/VREF+ pin or AVDD, whichever is selected as the VREFH source. VREFL current is from RA2/AN2/VREF- pin or AVss, whichever is selected as the VREFL source.

#### 29.1 Package Marking Information (Continued)

#### 40-Lead PDIP



#### Example



#### 44-Lead TQFP



### Example



#### 44-Lead QFN

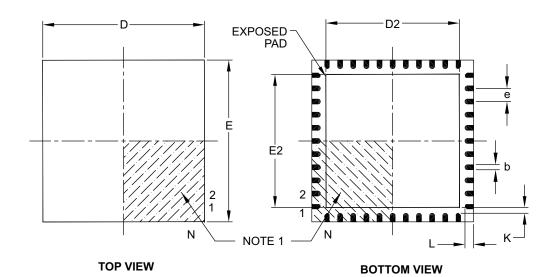


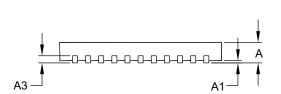
#### Example

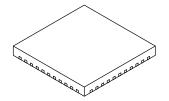


### 44-Lead Plastic Quad Flat, No Lead Package (ML) – 8x8 mm Body [QFN]

**Note:** For the most current package drawings, please see the Microchip Packaging Specification located at http://www.microchip.com/packaging







	Units		MILLIMETERS	3		
	Dimension Limits	MIN	NOM	MAX		
Number of Pins	N		44	•		
Pitch	е	0.65 BSC				
Overall Height	A	0.80	0.90	1.00		
Standoff	A1	0.00	0.02	0.05		
Contact Thickness	A3	0.20 REF				
Overall Width	E	8.00 BSC				
Exposed Pad Width	E2	6.30	6.45	6.80		
Overall Length	D		8.00 BSC	•		
Exposed Pad Length	D2	6.30	6.45	6.80		
Contact Width	b	0.25	0.30	0.38		
Contact Length	L	0.30	0.40	0.50		
Contact-to-Exposed Pad	К	0.20	_	_		

#### Notes:

- 1. Pin 1 visual index feature may vary, but must be located within the hatched area.
- 2. Package is saw singulated.
- 3. Dimensioning and tolerancing per ASME Y14.5M.

BSC: Basic Dimension. Theoretically exact value shown without tolerances.

REF: Reference Dimension, usually without tolerance, for information purposes only.

Microchip Technology Drawing C04-103B

Error Recognition Mode	330	G		
EUSART	0.44	GOTO		388
Asynchronous Mode		ш		
Associated Registers, Receive		Н		
Associated Registers, Transmit		Hardware Multiplier		
Auto-Wake-up on Sync Break		Introduction		117
Break Character Sequence		Operation		
Receiver		Performance Comparison		
Setting up 9-Bit Mode with Address Detect		High/Low-Voltage Detect		273
Transmitter	241	Applications		
Baud Rate Generator (BRG)	000	Associated Registers		277
Associated Registers		Characteristics		
Auto-Baud Rate Detect		Current Consumption		275
Baud Rate Error, Calculating		Effects of a Reset		277
Baud Rates, Asynchronous Modes		Operation		274
High Baud Rate Select (BRGH Bit)		During Sleep		277
Operation in Power-Managed Mode		Setup		275
Sampling		Start-up Time		275
Synchronous Master Mode		Typical Application		276
Associated Registers, Receive		HLVD. See High/Low-Voltage Detect		273
Associated Registers, Transmit				
Reception		I		
Transmission		I/O Ports		135
Synchronous Slave Mode		I <sup>2</sup> C Mode (MSSP)		
Associated Registers, Receive		Acknowledge Sequence Timing		224
Associated Registers, Transmit		Baud Rate Generator		217
Reception	252	Bus Collision		
Transmission	251	During a Repeated Start Condition		228
Extended Instruction Set		During a Stop Condition		
ADDFSR	410	Clock Arbitration		218
ADDULNK	410	Clock Stretching		210
CALLW	411	10-Bit Slave Receive Mode (SEN = 1)		
MOVSF	411	10-Bit Slave Transmit Mode		
MOVSS	412	7-Bit Slave Receive Mode (SEN = 1)		
PUSHL	412	7-Bit Slave Transmit Mode		
SUBFSR	413	Clock Synchronization and the CKP Bit		
SUBULNK	413	(SEN = 1)		211
External Clock Input	30	Effect of a Reset		
F		General Call Address Support		
F		I <sup>2</sup> C Clock Rate w/BRG		
Fail-Safe Clock Monitor	49, 361	Master Mode		
Interrupts in Power-Managed Modes	362	Operation		
POR or Wake-up from Sleep		Reception		
WDT During Oscillator Failure	361	Repeated Start Condition Timing		
Fast Register Stack	70	Start Condition		
Firmware Instructions	367	Transmission		
Flash Program Memory	101	Transmit Sequence		
Associated Registers	109	Multi-Master Communication, Bus Collision		
Control Registers		and Arbitration		225
EECON1 and EECON2	102	Multi-Master Mode		
TABLAT (Table Latch) Register	104	Operation		
TBLPTR (Table Pointer) Register	104	Read/Write Bit Information (R/W Bit)		
Erase Sequence	106	Registers		
Erasing		Serial Clock (RC3/SCK/SCL)		
Operation During Code-Protect		Slave Mode		
Reading				
Table Pointer		Addressing  Reception		
Boundaries Based on Operation	104	Transmission		
Table Pointer Boundaries				
Table Reads and Table Writes		Sleep Operation		
Write Sequence		Stop Condition Timing		
Writing To		ID Locations		
Protection Against Spurious Writes		INCF		
Unexpected Termination		INCFSZ		
Write Verify		In-Circuit Debugger		
FSCM See Fail-Safe Clock Monitor		In-Circuit Serial Programming (ICSP)	. 349,	300